

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/023,871	WAKAI ET AL.	
Examiner		Art Unit	3629	Page 1 of 1
Tan Dean D. Nguyen				

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,978,779	11-1999	Stein et al.	705/37
*	B	US-5,918,213	06-1999	Bernard et al.	705/26
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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